

Report No.: TWN2509542E

Applicant: Xplorys B.V.

Product: Dooky Luxe Stroller Fan (J25-24KS79 - M)

Trademark: N/A

Model No.: 5728150

Test Standards: EN IEC 55014-1:2021

EN IEC 55014-2:2021

EN IEC 61000-3-2:2019/A2:2024

EN 61000-3-3:2013+A2:2021+AC:2022-01

Test result:

The EMC testing has been performed on the

submitted samples and found in compliance with

council EMC Directive 2014/30/EU.

Approved By

Terry long

Terry Tang

Manager

Dated: September 26, 2025

Results appearing herein relate only to the sample tested The technical reports is issued errors and omissions exempt and is subject to withdrawal at

SHENZHEN TIMEWAY TESTING LABORATORIES.

Zone C, 1st Floor, Block B, Jun Xiang Da Building, Zhongshan Park Road West, Tong Le Village, Nanshan District, Shenzhen, China

Tel (755) 83448688 Fax (755) 83442996 Email: info@timeway-lab.com

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Special Statement:

FCC-Registration No.: 744189

The EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 744189.

ISED—Registration No.:5205A

The EMC Laboratory has been registered by Certification and Engineering Bureau of ISED for radio equipment testing with Registration No.: 5205A.

A2LA (Certification Number:5013.01)

The EMC Laboratory has been accredited by the American Association for Laboratory Accreditation (A2LA). Certification Number:5013.01

CAB identifier: CN0033

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Test Report Conclusion

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1.0 General Details

1.	1	Toot	Lah	Deta	:10
Ι.	1	Test	Lab	Deta	uis

Name: SHENZHEN TIMEWAY TESTING LABORATORIES.

Address: Zone C, 1st Floor, Block B, Jun Xiang Da Building, Zhongshan Park Road West, Tong

Le Village, Nanshan District, Shenzhen, China

Telephone: (086) 755-83448688 Fax: (086) 755-83442996

1.2 Applicant Details

Applicant: Xplorys B.V.

Address: Dopplerstraat 12 - 1704 SR Heerhugowaard The Netherlands

1.3 Description of EUT

Product: Dooky Luxe Stroller Fan (J25-24KS79 - M)

Manufacturer: Xplorys B.V.

Address: Dopplerstraat 12 - 1704 SR Heerhugowaard The Netherlands

Trademark: N/A
Model Number: 5728150
Additional Model Number: N/A

Rating: Input: DC5V, 40mA, 0.2W

EUT Type: ☐ Category I ☐ Category II ☐ Category IV

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1.4 Submitted Sample: 1 Sample

1.5 Test Duration:

Date of Receipt of Application: September 18, 2025 Date of Test: September 18, 2025 ~ September 26, 2025

1.6 Test Uncertainty

Conducted Emissions Uncertainty =3.6dB Disturbance Power Uncertainty =4.2dB

1.7 Test or witness Engineer

The sample tested by

Print Name: Leo Lau

Les. Lan

Date: 2025-09-26



2.0 List of Measurement Equipment

2.1 Conducted Emission Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EMI Test Receiver	ESCS 30	834115/006	RS	2025.07.11	1Year
LISN	NNB42	00012	SCHAFFNER	2025.07.11	1Year

2.2 Radiated Disturbance Test

				Calibration	Calibration
Name	Model No	Serial No.	Manufacturer	Date	Cycle
EMI Test Receiver	ESPI 3	100379	RS	2025.07.11	1Year
Spectrum Analyzer	E4407B	MY50441392	HP/Agilent	2025.07.11	1Year
Amplifier	BBV9743	#218	HP/Agilent	2025.07.11	1Year
Bilog Antenna	VULB9163	9163/340	Schwarebeck	2025.07.17	3Year
Horn Antenna	BBHA 9120D	9120D-631	RS	2025.07.17	3Year
Amplifier	8449B	3008A00160	HP/Agilent	2025.07.11	1Year

2.3 Harmonic & Flicker Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Harmonics Flicker Test					
System	PACS-1	72305	CI	2025.07.11	1Year
5K VA AC Power					
Source	5001iX	56060	CI	2025.07.11	N/A

2.4 ESD Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
ESD Simulator	ESS-2002	ESS06Y6394	NoiseKen	2025.07.11	1Year

2.5 RF field Strength Susceptibility

2.e Ta Hera Swengen Susceptionity								
				Calibration	Calibration			
Name	Model No.	Serial No.	Manufacturer	Date	Cycle			
Signal Generator	SMT03	100059	RS	2025.07.11	1Year			
Power Meter	NRVS		RS	2025.07.11	1Year			
Voltage Probe	URV5-Z2	100012	RS	2025.07.11	1Year			
Voltage Probe	URV5-Z2	100013	RS	2025.07.11	1Year			

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Power Amplifier	150W1000	300999	AR	2025.07.11	1Year
Power Amplifier	25S1G4AM1	305993	AR	2025.07.11	1Year
Field Probe	CBL6111C	2576	Holaday	2025.07.11	1Year
Bilog Antenna	MCDC		Chase	2025.07.11	1Year

2.6 Electrical Fast Transient/Burst (EFT/B) Immunity test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EFT Generator	UCS 500 M4	0304-42	EM TEST	2025.07.11	1Year
Power Source	MV2616	0104-14	EM TEST	2025.07.11	1Year

2.7 Surge Test

					Calibration
Name	Model No.	Serial No.	Manufacturer	Calibration Date	Cycle
Ultra Compact	UCS 500				
Simulator	M4	0304-42	EM TEST	2025.07.11	1Year
Power Source	MV2616	0104-14	EM TEST	2025.07.11	1Year

2.8 Conducted Immunity Test

					Calibration	Calibration
Name		Model No.	Serial No.	Manufacturer	Date	Cycle
Continuous	Wave					
Simulator		CWS 500C	0407-05	EM TEST	2025.07.11	1 Year

2.9 Power-frequency Magnetic Field

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Continuous Wave					
Simulator	UCS 500 M4	0304-42	EM TEST	2025.07.11	1 Year
Power Source					
Network	MV 2616	0104-14	EM TEST	2025.07.11	1 Year
Current Transformer	MC2630		EM TEST	2025.07.11	1 Year
Magnetic Coil	MS100	0304-42	EM TEST	2025.07.11	1 Year

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2.10 Voltage Dips/Interruption Immunity Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Ultra Compact					
Simulator	UCS 500 M4	0304-42	EM TEST	2025.07.11	1Year
Power Source	MV2616	0104-14	EM TEST	2025.07.11	1Year

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3.0 Technical Details

3.1 Investigations Requested

Perform Electromagnetic Interference [EMI] & Electromagnetic Susceptibility [EMS] tests for CE Marking

3.2 Test Standards

	Test Standards								
EN IEC 55014-1:2021		Requirements household appliances,							
	electric tools and similar apparatu	is—Part 1: Emission							
EN IEC 61000-3-2:	Electromagnetic compatibility (EMC)- Part 3-2:Limits-Limits for								
2019/A2:2024	harmonic current emissions(equip	oment input current ≤16A per phase)							
	Electromagnetic compatibility (E	Electromagnetic compatibility (EMC)- Part 3-3: Limits-Limitation of							
EN 61000-3-3:2013	voltage changes, Voltage fluctuat	tions and flicker in public low-voltage							
+A2:2021+AC:2022-01	supply systems. For equipment	supply systems. For equipment with rated current ≤16A per phase							
	and not subject to conditional connection								
	Electromagnetic compatibility—F	Requirements household							
EN IEC 55014-2:2021	appliances, electric tools and simi	lar apparatus— Part2: Immunity							
	—Product family standard								
	EN 61000-4-2:2009	Elect ostatic discharge							
	EN IEC 61000-4-3:2020	RF field strength susceptibility							
	EN 61000-4-4:2012	Electrical Fast transients							
	EN 61000-4-5:2014	Surge							
	EN 61000-4-6:2014	Conducted susceptibility							
	EN 61000-4-8:2010	Magnetic Field							
	EN IEC 61000-4-11:2020	Dips/Voltage Interruption Variation							

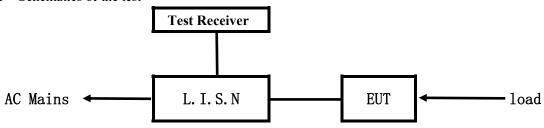
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4.0 Power line Conducted Emission Test

4.1 Schematics of the test

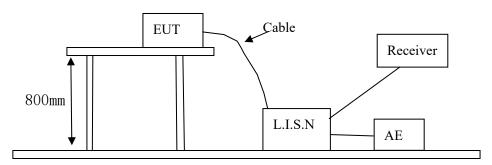


EUT: Equipment Under Test

4.2 Test Method:

The test was performed in accordance with EN IEC 55014-1:2021

Block diagram of Test setup



4.3 Power line conducted Emission Limit

Engayon ov. (MII-)	Limits dB(μ V)				
Frequency (MHz)	Quasi-peak Level	Average Level			
0.15 ~ 0.50	66.0~56.0*	59.0~46.0*			
$0.50 \sim 5.00$	56.0	46.00			
5.00 ~ 30.00	60.0	50.00			

Notes:

- 1. *decreasing linearly with logarithm of frequency.
- 2. The lower limit shall apply at the transition frequencies

4.4 Test Results

Limits for Conducted Emission test, Please refer to limit line (Quasi-peak) in the following diagram labelled as (QP)

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A: Disturbance Voltage Limits at mains on Live terminals (150kHz to 30MHz)

EUT Operating Environment

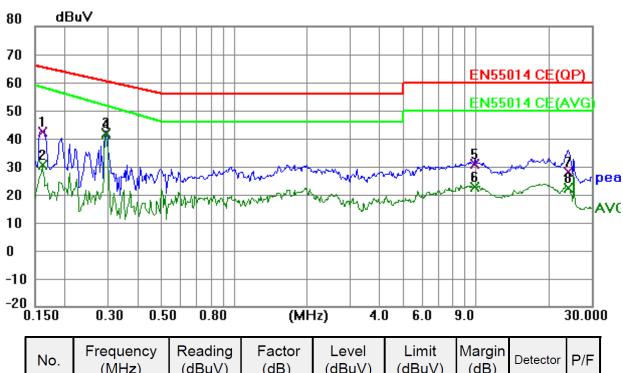
Temperature: 25°C Humidity:65%RH Atmospheric Pressure: 101 kPa

EUT set Condition: Working + Charging

Power: AC230V/50Hz

Results: Pass

Please refer to following diagram for individual



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F
1	0.1617	32.10	10.34	42.44	65.38	-22.94	QP	Р
2	0.1617	20.23	10.34	30.57	58.19	-27.62	AVG	П
3	0.2943	31.73	10.35	42.08	60.40	-18.32	QP	П
4	0.2943	31.40	10.35	41.75	51.72	-9.97	AVG	П
5	9.8718	17.01	13.78	30.79	60.00	-29.21	QP	Р
6	9.8718	9.04	13.78	22.82	50.00	-27.18	AVG	Р
7	23.9703	12.44	15.57	28.01	60.00	-31.99	QP	Р
8	23.9703	6.61	15.57	22.18	50.00	-27.82	AVG	Р

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B: Disturbance Voltage Limits at mains on Neutral terminals (150kHz to 30MHz)

EUT Operating Environment

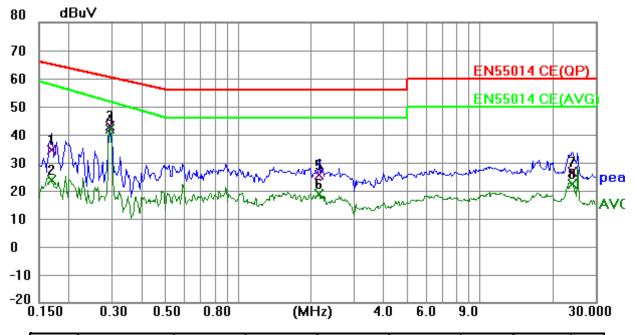
Temperature: 25°C Humidity:65%RH Atmospheric Pressure: 101 kPa

EUT set Condition: Working + Charging

Power: AC230V/50Hz

Results: Pass

Please refer to following diagram for individual



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F
1	0.1695	23.99	10.33	34.32	64.98	-30.66	QP	Р
2	0.1695	13.40	10.33	23.73	57.68	-33.95	AVG	J
3	0.2943	32.53	10.35	42.88	60.40	-17.52	QP	П
4	0.2943	31.50	10.35	41.85	51.72	-9.87	AVG	Р
5	2.1662	13.99	11.38	25.37	56.00	-30.63	QP	Р
6	2.1662	7.22	11.38	18.60	46.00	-27.40	AVG	Р
7	24.0834	11.15	15.55	26.70	60.00	-33.30	QP	Р
8	24.0834	6.78	15.55	22.33	50.00	-27.67	AVG	Р

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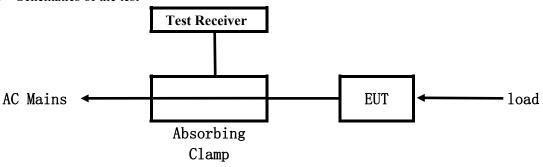
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5.0 Disturbance Power Test

5.1 Schematics of the test

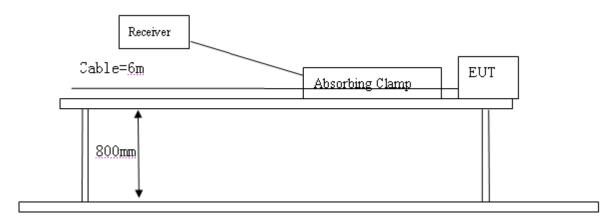


EUT: Equipment Under Test

5.2 Test Method:

The test was performed in accordance with EN IEC 55014-1:2021

Block diagram of Test setup



5.3 Results and limits line for Distance power

N/A

Limits for Disturbance power Test, please refer to limit lines (Quasi-peak) in the following diagram labelled as (QP)

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6.0 Radiated Disturbance Test

6.0.1 Schematics of the test

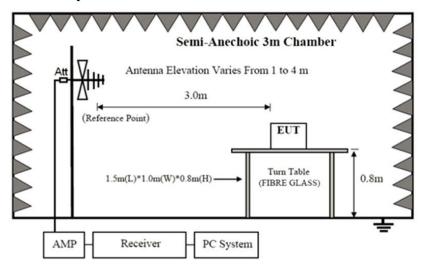


EUT: Equipment Under Test

6.0.2 Test Method:

The test was performed in accordance with EN IEC 55014-1:2021

Block diagram of Test setup



6.0.3 Radiated Disturbance Test Limit

English Daniel (MII-)	Quasi-Peak limits (dB μ V/m)				
Frequency Range (MHz)	Class A Limits	Class B Limits			
30-300	50.00	40.00			
300-1000	57.00	47.00			

Note: The lower limit shall apply at the transition frequencies

6.0.4 Test result

Limits for Radiated Disturbance test, Please refer to limit line (Quasi-peak) in the following diagram labelled as (QP)

Remark:

Calculated measurement uncertainty=4.7dB

The report refers only to the sample tested and does not apply to the bulk.

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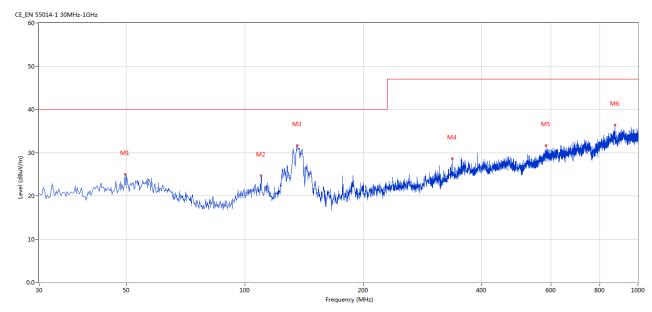
A: Radiated Disturbance (30MHz----1GHz)

Project Number: CASE2 Test Time: 2025-09-25_14.02.33

EUT Name: Dooky Luxe Stroller Fan (J25-24KS79 - M) Test Engineer: CHASE

Manufacturer: Xplorys B.V. Test Standard: EN 55014 Model: 5728150 Work Addition: Charging

Temp.($^{\circ}$): 25 Load:



No.	Frequency	Results	Factor	Limit	Margin	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	49.638	24.97	-8.83	40.0	15.03	Peak	328.00	100	Horizontal	Pass
2	110.005	24.64	-9.45	40.0	15.36	Peak	303.00	100	Horizontal	Pass
3	135.946	31.62	-13.22	40.0	8.38	Peak	182.00	100	Horizontal	Pass
4	336.928	28.60	-6.21	47.0	18.40	Peak	86.00	100	Horizontal	Pass
5	584.459	31.59	-1.90	47.0	15.41	Peak	222.00	100	Horizontal	Pass
6	872.962	36.39	2.23	47.0	10.61	Peak	138.00	100	Horizontal	Pass

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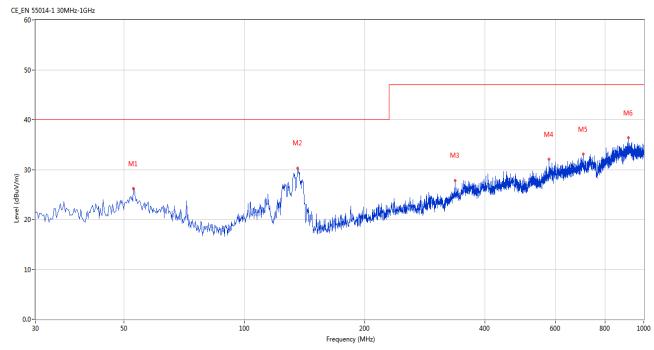
B: Radiated Disturbance (30MHz----1GHz)

Project Number: CASE2 Test Time: 2025-09-25_14.01.12

EUT Name: Dooky Luxe Stroller Fan (J25-24KS79 - M) Test Engineer: CHASE

Manufacturer: Xplorys B.V. Test Standard: EN 55014 Model: 5728150 Work Addition: Charging

Temp.($^{\circ}$): 25 Load:



No.	Frequency	Results	Factor	Limit	Margin	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	52.789	26.16	-8.14	40.0	13.84	Peak	169.00	100	Vertical	Pass
2	135.946	30.32	-13.22	40.0	9.68	Peak	31.00	100	Vertical	Pass
3	336.928	27.84	-6.21	47.0	19.16	Peak	284.00	100	Vertical	Pass
4	579.125	32.04	-1.75	47.0	14.96	Peak	187.00	100	Vertical	Pass
5	705.194	33.11	-0.24	47.0	13.89	Peak	224.00	100	Vertical	Pass
6	914.661	36.33	2.80	47.0	10.67	Peak	62.00	100	Vertical	Pass

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C: Radiated Disturbance (30MHz----1GHz)

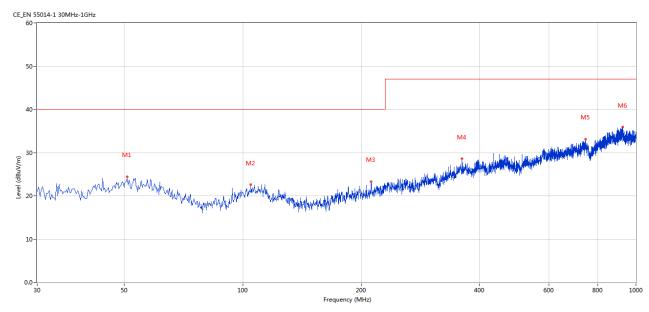
Project Number: CASE2 Test Time: 2025-09-25_14.05.00

EUT Name: Dooky Luxe Stroller Fan (J25-24KS79 - M) Test Engineer: CHASE

Manufacturer: Xplorys B.V. Test Standard: EN 55014

Model: 5728150 Work Addition: Working

Temp.($^{\circ}$): 25 Load:



No.	Frequency	Results	Factor	Limit	Margin	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	50.850	24.44	-8.43	40.0	15.56	Peak	70.00	100	Horizontal	Pass
2	104.914	22.57	-9.76	40.0	17.43	Peak	353.00	100	Horizontal	Pass
3	212.072	23.33	-10.17	40.0	16.67	Peak	133.00	100	Horizontal	Pass
4	360.930	28.54	-5.09	47.0	18.46	Peak	135.00	100	Horizontal	Pass
5	744.954	33.16	-0.07	47.0	13.84	Peak	324.00	100	Horizontal	Pass
6	924.359	35.91	2.75	47.0	11.09	Peak	269.00	100	Horizontal	Pass

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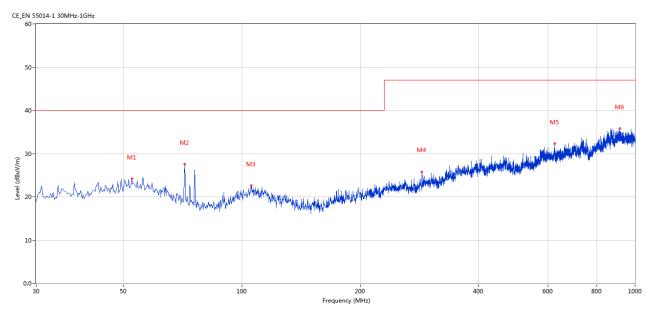
D: Radiated Disturbance (30MHz----1GHz)

Project Number: CASE2 Test Time: 2025-09-25_14.23.29

EUT Name: Dooky Luxe Stroller Fan (J25-24KS79 - M) Test Engineer: CHASE

Manufacturer: Xplorys B.V. Test Standard: EN 55014 Model: 5728150 Work Addition: Working

Temp.($^{\circ}$): 25 Load:



No.	Frequency	Results	Factor	Limit	Margin	Detector	Table	Height	Antenna	Verdict
	(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dB)		(Degree)	(cm)		
1	52.547	24.20	-8.24	40.0	15.80	Peak	144.00	100	Vertical	Pass
2	71.700	27.58	-11.22	40.0	12.42	Peak	266.00	100	Vertical	Pass
3	105.641	22.58	-9.57	40.0	17.42	Peak	87.00	100	Vertical	Pass
4	286.986	25.80	-7.87	47.0	21.20	Peak	298.00	100	Vertical	Pass
5	624.946	32.30	-1.47	47.0	14.70	Peak	276.00	100	Vertical	Pass
6	913.934	35.84	2.77	47.0	11.16	Peak	347.00	100	Vertical	Pass

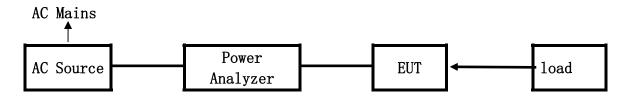
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7.0 Voltage Fluctuations & Flicker Test

7.1 Schematic of the test



EUT: Equipment Under Test

7.2 Test Method:

The test was performed in accordance with EN 61000-3-3:2013+A2:2021+AC:2022-01

7.3 Test Results

Result: N/A

Maximum Occurring Levels:

Ut: 230.1 (EUT Test RMS Voltage)

Pst:	Limit=	1.0	(The Highest short Term Flicker Value)
Plt:	Limit=	0.65	(The Highest Long Term Flicker Value)
dt(%):	Limit=	3.3%	(The Highest instantaneous Voltage Change (10ms))
dc(%):	Limit=	3.3%	(The highest Relative steady state voltage change (1sec))
dmax:	Limit=	4%	(The highest Max Relative voltage change)
Tdt:	Limit=	500ms	(The Max Time(in milli-sec) that dt exceeds 3%)

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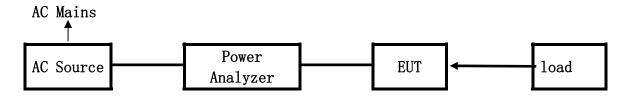
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8.0 Harmonic Current Emission Test

8.1 Schematic of the test



EUT: Equipment Under Test

8.2 Test Method

The test was performed in accordance with EN IEC 61000-3-2:2019/A2:2024

8.3 Test Results

Result: N/A

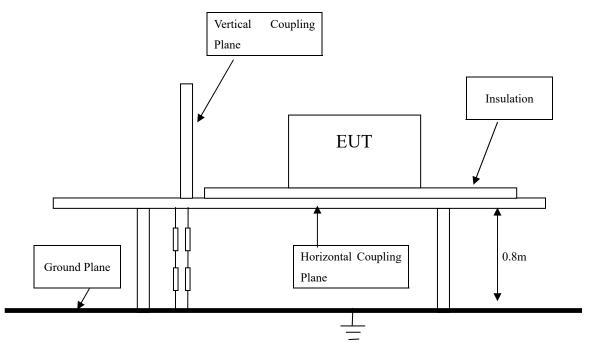
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9.0 Electrostatic Discharge

9.1 Schematic of the test



9.2 Test method

The test was performed in accordance with EN 61000-4-2: 2009

9.3 Test severity

- ±4kV for direct & in-direct Contact Discharge
- ± 8 kV for air Discharge

Performance Criterion Require: B (Please see following table)

9.4 Susceptibility performance Criteria and Severity level

A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
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Severity Level

Level	Test Voltage Direct & in-direct contact	Test Voltage Air
	Discharge (kV)	discharge(kV)
1	±2kV	$\pm 2kV$
2	±4kV	±4kV
3	±6kV	±8kV
4	$\pm 8 \mathrm{kV}$	$\pm 15 kV$

9.5 Test Result

Please refer to the following table for individual results.

Location	Discharge Method	Test Voltage	Results
HCP (Horizontal coupling plane)	In-Direct	$\pm 2kV$, $\pm 4kV$	Pass
VCP (Vertical Coupling plane)	In-Direct	$\pm 2kV$, $\pm 4kV$	Pass
	Contact Discharge	$\pm 2kV$, $\pm 4kV$	Pass
Enclosure	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass
Keys	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass
DC Jack	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass

Remark: Calculated measurement uncertainty=0.2kV

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10.0 RF field strength susceptibility (80MHz----- 1000MHz)

10.1 Schematics of the test



10.2 Test Method:

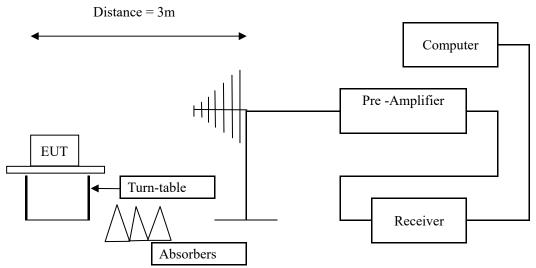
The test was performed in accordance with EN IEC 61000-4-3:2020

Severity: Level 2 (3V/m)

Modulation: 80% AM

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



10.3 Susceptibility performance Criteria and severity Level

Susceptibility performance Criteria

A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
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Severity Level

Level	Field Strength (V/m)
1	1
2	3
3	10

10.4 Test Result:

Please refer to the following table for individual results.

Frequency (MHz)	Face	Polarity	Level (V/m)	Dwell Time(s)	Sweep Rate (%)	Results
80-1000	0°	Horizontal	3	1	1	Pass
80-1000	90°	Horizontal	3	1	1	Pass
80-1000	180°	Horizontal	3	1	1	Pass
80-1000	270°	Horizontal	3	1	1	Pass
80-1000	0°	Vertical	3	1	1	Pass
80-1000	90°	Vertical	3	1	1	Pass
80-1000	180°	Vertical	3	1	1	Pass
80-1000	270°	Vertical	3	1	1	Pass

Remark: Calculated measurement uncertainty= 80MHz to 1000MHz (+3.7/-1.3) V/m

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11.0 Electrical Fast Transient/Burst (EFT/B) immunity test

11.1 Schematics of the test



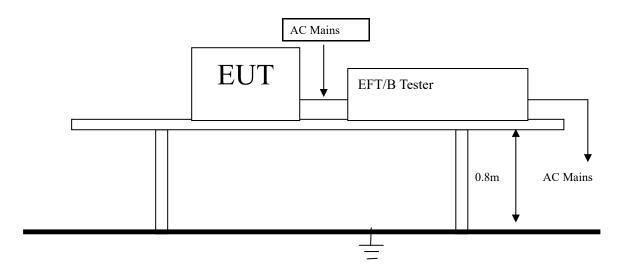
11.2 Test Method:

The test was performed in accordance with EN 61000-4-4: 2012

Severity: Level 2 (1kV)

Performance Criterion Require: B (Please see following table)

Block diagram of Test setup



11.3 Susceptibility performance Criteria and Severity Level Susceptibility performance Criteria

A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is self recoverable
С	Temporary degradation or loss of function or performance which requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to damage of equipment(components) or software, or loss of data

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Severity Level

	Open Circuit output Test Voltag	$\pm 10\%$
Level	On power Supply Lines	On I/O (Input/output)
		Signal data and control lines
1	0.5kV	0.5kV
2	1kV	1kV
3	2kV	2kV
4	4kV	4kV
X	Special	Special

11.4 Test Results

Please refer to following page.

Inject location:

Inject Line	Voltage kV	Inject Times (s)	Method	Results
L	±1	120	Direct	Pass
N	±1	120	Direct	Pass
L-N	±1	120	Direct	Pass
PE	±1	120	Direct	N/A
L-PE	±1	120	Direct	N/A
N-PE	±1	120	Direct	N/A
L-N-PE	±1	120	Direct	N/A

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12.0 Surge test

12.1 Schematics of the test



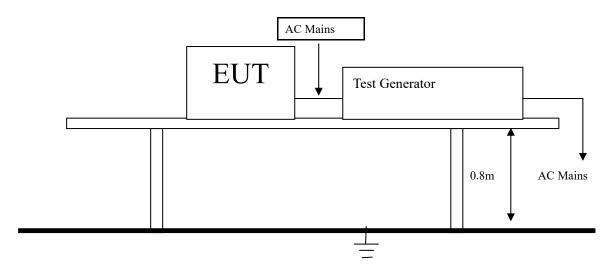
12.2 Test Method:

The test was performed in accordance with EN 61000-4-5:2014

Severity: Level 2 (Line to Neutral at 1kV)

Performance Criterion Require: C (Please see following table)

Block diagram of Test setup



12.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
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Severity Level

Severity Level	Open-Circuit Test Voltage		
	kV		
1	0.5		
2	1.0		
3	2.0		
4	4.0		
*	Special		

12.4 Test Results

Please refer to following page.

Test location:

Location	Polarity	Phase	No of	Pulse	Results
		Angle	Pulse	Voltage(kV)	
L-N	+	90	5	1.0	Pass
	-	270	5	1.0	Pass
L, N -PE	+	90	5	2.0	N/A
	-	270	5	2.0	N/A

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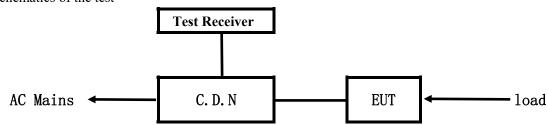
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13.0 Conducted Immunity test

13.1 Schematics of the test



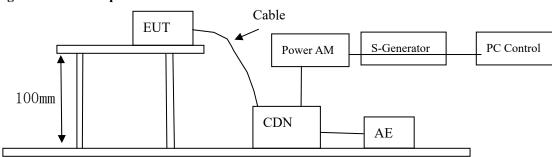
13.2 Test Method

The test was performed in accordance with EN 61000-4-6:2014

Severity: Level 2 (3 V rms),0.15MHz—230MHz

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



13.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

1 / 1	
A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to
	damage of equipment(components) or software, or loss of data

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Severity Level

Severity Level	Field Strength V/m		
1	1		
2	3		
3	10		
*	Special		

13.4 Test Results:

Please refer to the following page

Frequency	Injected Position	Strength	Criterion	Result
Range (MHz)				
0.15 - 20	AC Line	3V (rms) Unmodulated	A	Pass
20 - 230	AC Line	3V (rms) Unmodulated	A	Pass

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14.0 Voltage Dips/Interruptions immunity test

14.1 Schematics of the test

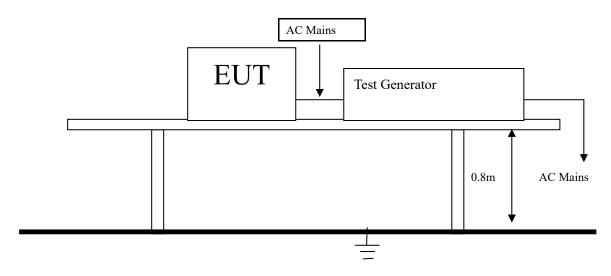


14.2 Test Method:

The test was performed in accordance with EN IEC 61000-4-11: 2020

Performance Criterion Require: C&B (Please see following table)

Block diagram of Test setup



14.3 Susceptibility performance Criteria and Severity Level Susceptibility performance Criteria

A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is
	self recoverable
С	Temporary degradation or loss of function or performance which
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Severity Level

Test Level %Ut	Voltage dip and short interruptions %Ut	Duration (in period)
0	100	0.5
40	60	5 10
70	30	25 50 *

14.4 Test Result:

Please refer to the following page

Test Level	Voltage	Duration (in	Phase Angle	Criterion	Result			
% Ut	dips &short	period)						
	interruptions %							
	Ut							
50Hz	50Hz							
0	100	0.5P	0° - 360°	В	Pass			
40	60	10P	0° - 360°	C	Pass			
70	30	25P	0° - 360°	C	Pass			
60Hz								
0	100	0.5P	0° - 360°	В	Pass			
40	60	12P	0° - 360°	С	Pass			
70	30	30P	0° -360°	С	Pass			

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15.0 Product Labelling

15.1 CE Mark label specification

Text of the mark is black or white in color and is left justified. Labels are printed in indelible ink on permanent adhesive backing and shall be affixed at a conspicuous location on the EUT or silk-screened onto the EUT.



15.2 Mark Location: On rear enclosure

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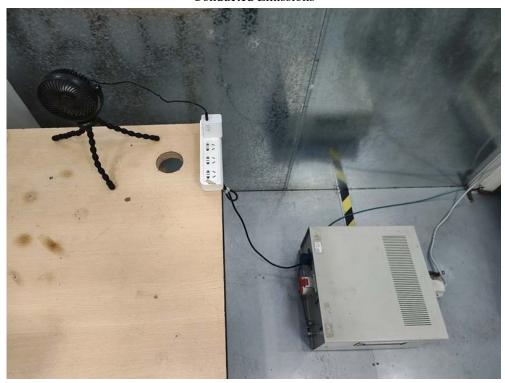
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Appendix:

Conducted Emissions



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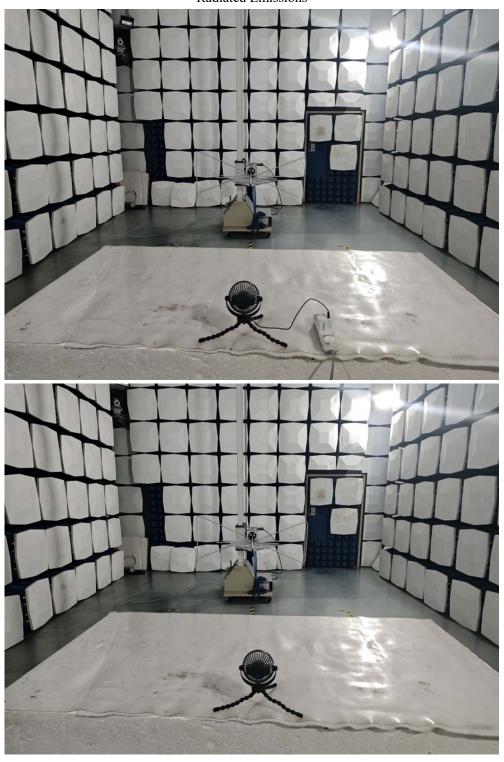
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Appendix:

Radiated Emissions



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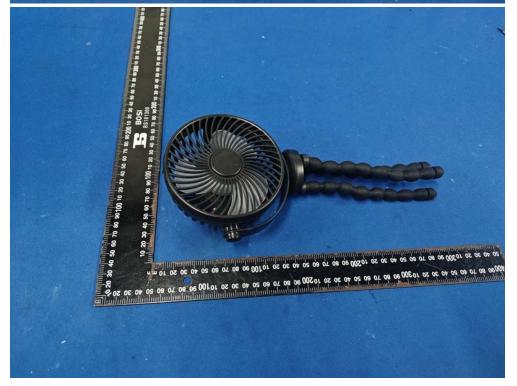
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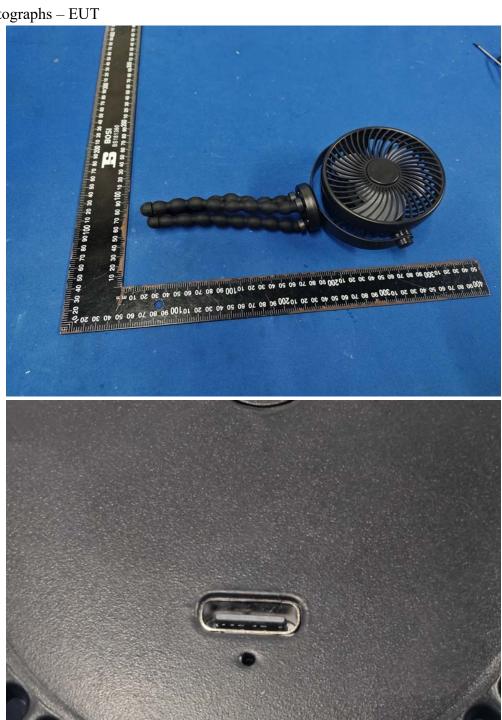
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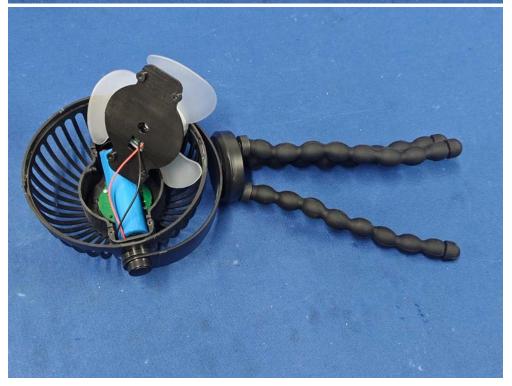
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Photographs – EUT





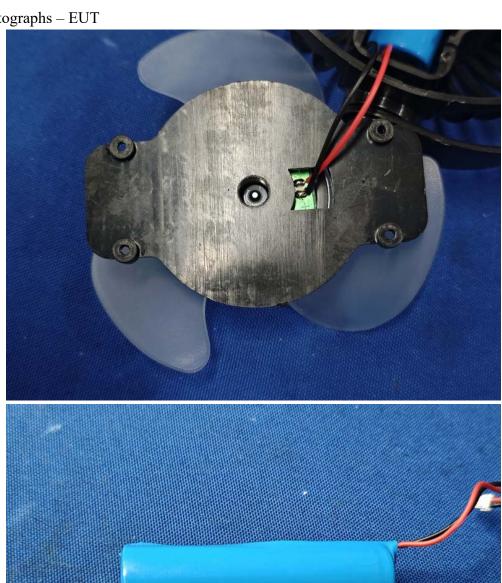
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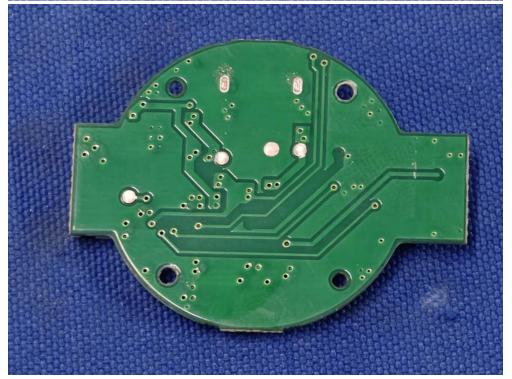
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